

# Device Modeling Report

COMPONENTS:  
DIODE/ GENERAL PURPOSE RECTIFIER / STANDARD  
PART NUMBER: RHRG75120  
MANUFACTURER: INTERSIL  
REMARK: TC= 110C

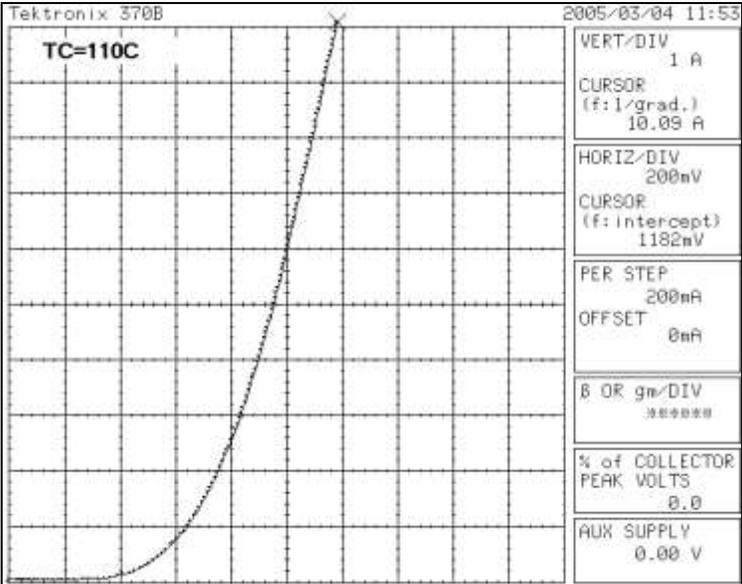


**Bee Technologies Inc.**

PSpice model parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time
EG	Energy-band Gap

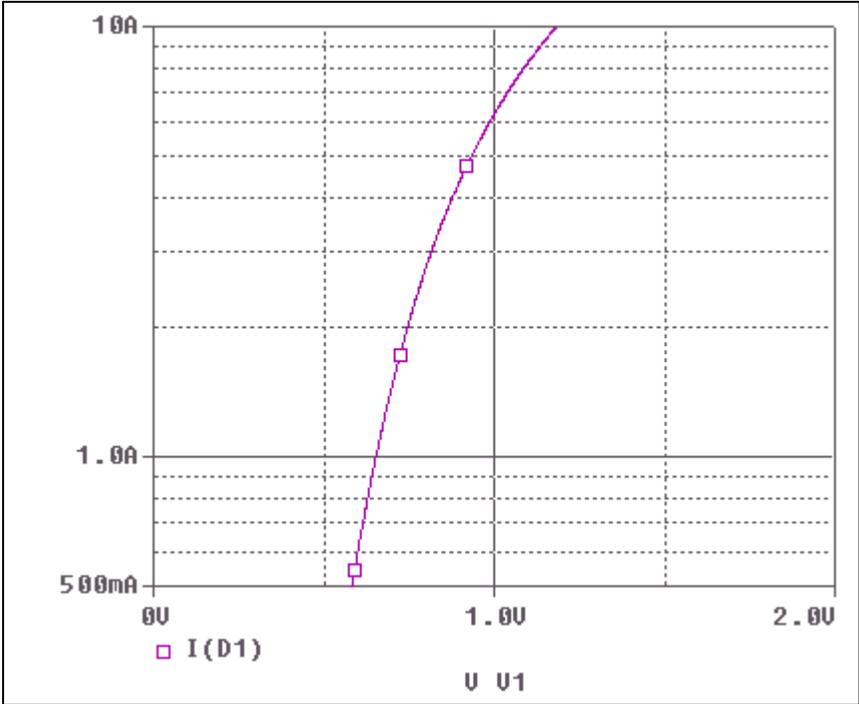
# Forward Current Characteristic

# Reference

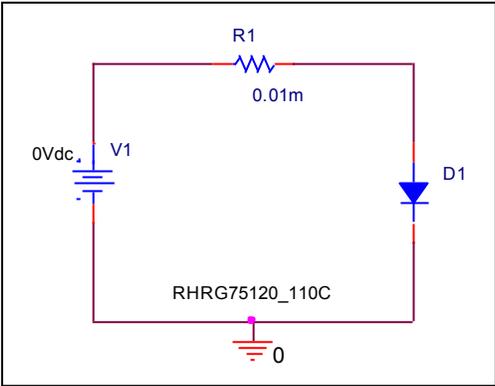


# Forward Current Characteristic

## Circuit Simulation Result

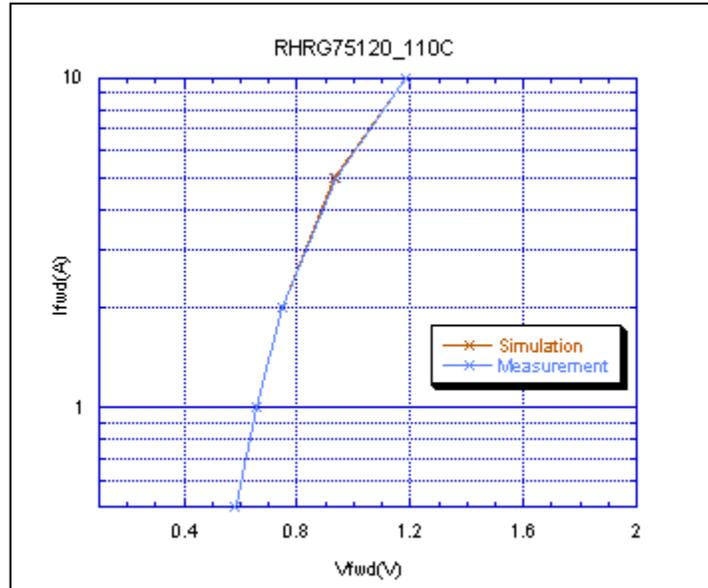


## Evaluation Circuit



## Comparison Graph

### Circuit Simulation Result

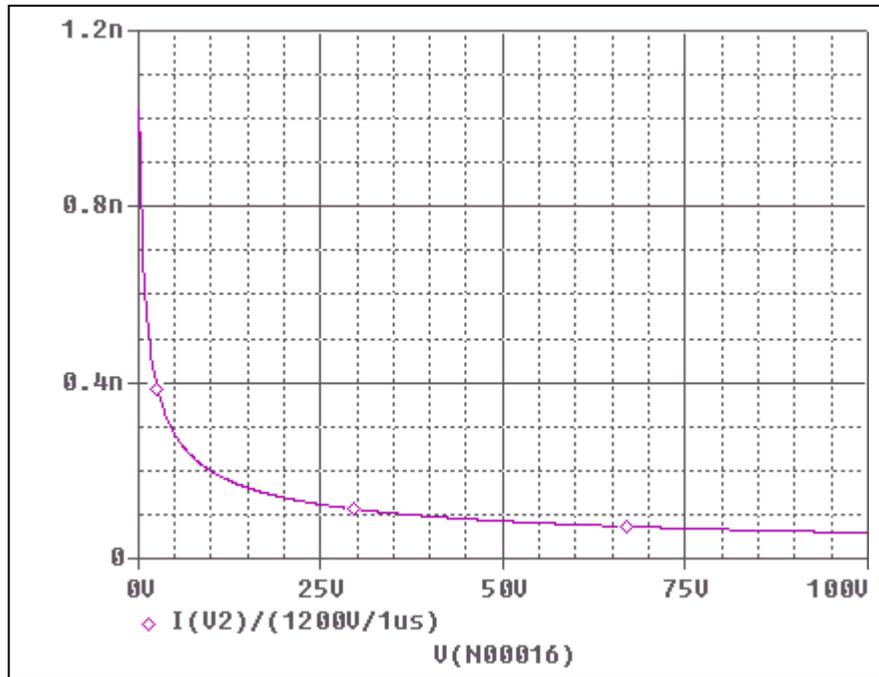


### Simulation Result

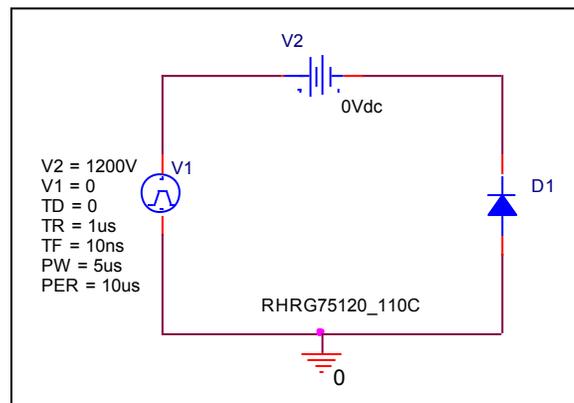
Ifwd(A)	Vfwd(V) Measurement	Vfwd(V) Simulation	%Error
0.5	0.576	0.581	-0.87
1	0.654	0.653	0.15
2	0.750	0.747	0.40
5	0.934	0.933	0.11
10	1.182	1.182	0.00

# Capacitance Characteristic

## Circuit Simulation Result

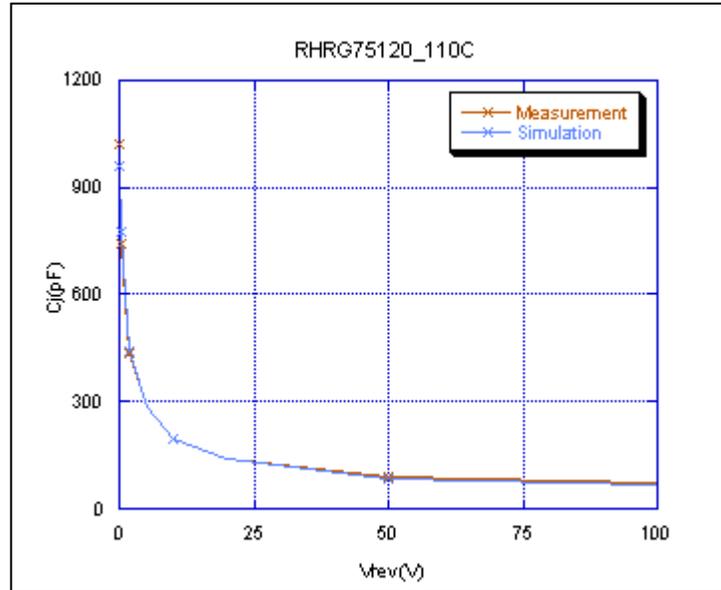


## Evaluation Circuit



## Comparison Graph

### Circuit Simulation Result

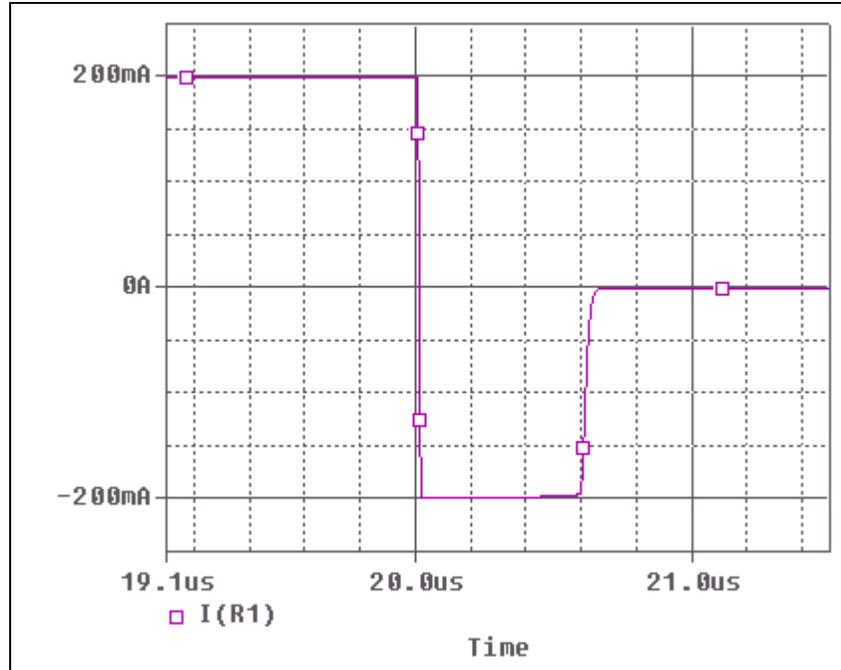


### Simulation Result

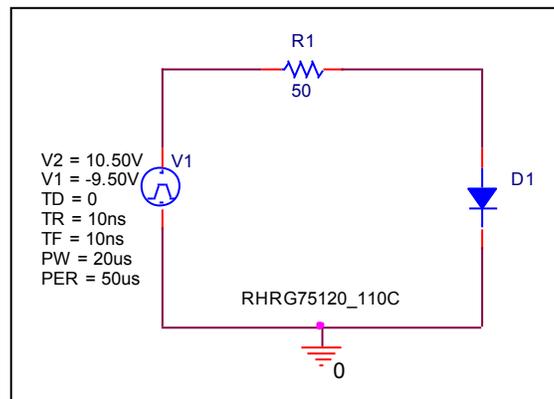
Vrev(V)	Cj(pF) Measurement	Cj(pF) Simulation	%Error
0	1134.000	1134.000	0.00
0.1	1021.000	959.978	5.98
0.2	930.100	952.261	-2.38
0.5	740.274	777.189	-4.99
1	578.190	596.334	-3.14
2	434.846	442.363	-1.73
5	283.081	285.947	-1.01
10	195.437	198.719	-1.68
20	138.995	138.247	0.54

# Reverse Recovery Characteristic

## Circuit Simulation Result



## Evaluation Circuit

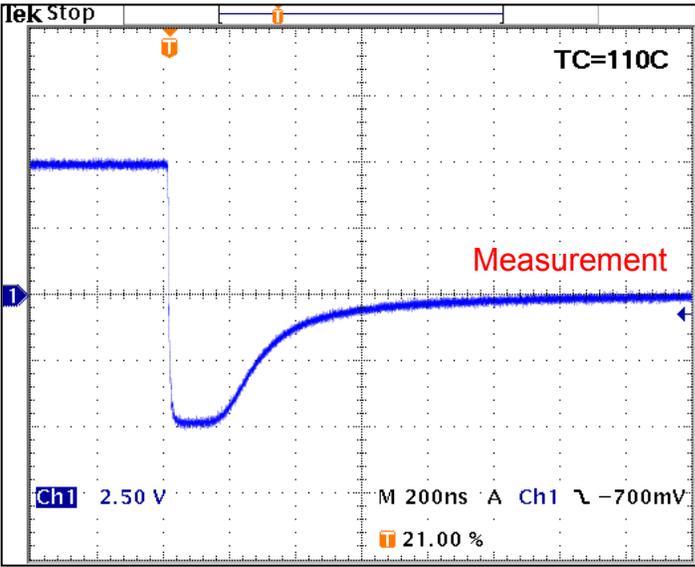


## Compare Measurement vs. Simulation

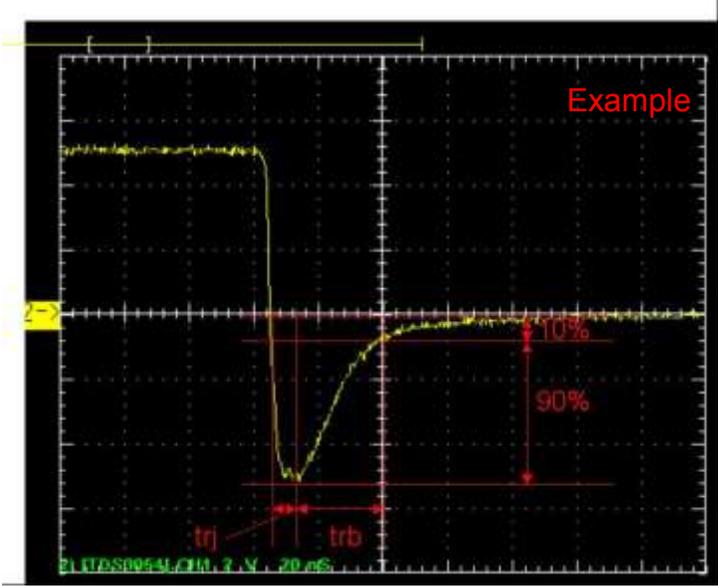
	Measurement		Simulation		%Error
trr	584.0	ns	583.5	ns	0.489

# Reverse Recovery Characteristic

# Reference



Trj =132 (ns)  
Trb= 452 (ns)  
Conditions: Ifwd=Irev=0.2(A), RI=50



Relation between trj and trb